IAP20 Rec'el Telletto 25 JAN 2006

PTO/SB/08a/b (07-05)

Approved for use through 07/31/2008. OMB 0651-0031

U.S. Patent and Trademark Office; U.S. DEPARTMENT OF COMMERCE

Under the Paperwork Reduction Act of 1995, no persons are required to respond to a collection of information unless it contains a valid OMB control number.

Complete if Known Substitute for form 1449A/B/PTO Application Number INFORMATION DISCLOSURE Filing Date **Concurrently Herewith** STATEMENT BY APPLICANT First Named Inventor Mark Duda Art Unit N/A (Use as many sheets as necessary) Not Yet Assigned Examiner Name of Sheet 1 2 12810-00191-US1 Attorney Docket Number

U.S. PATENT DOCUMENTS						
Examiner Initials*	Cite No.1	Document Number Number-Kind Code ² (if known)	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear	
150	AA*	US-20040014990-A1	01-22-2004	Storck et al.		
RA	AB*	US-3,474,041	10-21-1969	Kerr et al.		
BO	AC*	US-3,904,652	09-09-1975	Frank et al.		
14	AD.	US-4,231,943	11-04-1980	Paradis et al.		
m	AE*	US-4,342,699	08-03-1982	Palmer et al.		
m	AF*	US-4,511,670	04-16-1985	Suciu et al.		
BIT	AG*	US-4,795,818	01-03-1989	Becker et al.		
Bn	AH*	US-4,933,312	06-12-1990	Haddad et al.		
30		US-5,011,945	04-30-1991	Taheri		
	AJ*	US-5,137,860	08-11-1992	Ebner et al.		
160	AK*	US-5,095,125	03-10-1992	Haddad et al.		
	AL*	US-5,158,923	10-27-1992	Barone		
132	AM*	US-5,275,996	01-04-1994	Andrews et al.		
DI	AN*	US-5,296,436	03-22-1994	Bortinger		
131	AO*	US-5,302,566	04-12-1994	Schwartz		
1/1/	AP*	US-5,498,731	03-12-1996	Tsurita et al.		
120	AQ*	US-4,525,471	06-25-1985	Bremer et al.		
Pol	AR*	US-5,532,384	07-02-1996	Shirley et al.		
4/	AS*	US-5,641,722	06-24-1997	Mitchell et al.		
BA	AT*	US-5,646,304	07-08-1997	Acharya et al.		
	AU*	US-5,726,327	03-10-1998	Acharya et al.		
M	AV*	US-6,002,019	12-14-1999	Tamhankar et al.		
130	AW*	US-6,040,460	03-21-2000	Bertola et al.		
BO	AX*	US-6,803,473	10-12-2004	Weiguny et al.		
BI	AY*	US-6,812,351	11-02-2004	Weiguny		

FOREIGN PATENT DOCUMENTS								
Examiner Initials*	Cite No.1	Foreign Patent Document	Publication Date MM-DD-YYYY	Name of Patentee or Applicant of Cited Document	Pages, Columns, Lines, Where Relevant Passages or Relevant Figures Appear			
		Country Code ³ -Number ⁴ -Kind Code ⁸ (if known)				10		
BI	ВА	EU-0029317	05-27-1981	Imperial Chemical Industries Limited		7		
130	BB	EU-0099431	02-01-1984	Standard Oil Company		1		
Bn	ВС	EU-0690040	01-03-1996	SISAS Societa'Italiana Serie Acetica E Sintetica Spa		1		
10	BD	EU-1004567	05-31-2000	Mitsubishi Chemical Corporation		7		
150	BE	DE-391633	11-12-1990	Lummus Crest Inc.				
130	BF	DE-10211445	10-02-2003	BASF AG				
JAN.	/BG	DE-10211446.	10-02-2003	BASF AG				
1300	ВН	DE-10211447	10-02-2003	BASF AG				
BII	Ві	DE-10211449	09-25-2003	BASF AG				
BA	BJ	DE-10235355	02-19-2004	BASF AG				
130	ВК	WO-95/26817	10-12-1995	El Du Pont De Nemours and Company		1		

		<u> </u>		
Examiner Signature	15 &	ents	Date Considered .	1-5-07
441834				

IAP20 Recaliding 25 Jan 2006

PTO/SB/08a/b (07-05)
Approved for use through 07/31/2008. OMB 0651-0031
U.S. Patent and Trademark Office; U.S. DEPARTMENT OF COMMERCE

to a collection of information unless it contains a valid OMB control number

Sub	stitute for form 1449A/B	/PTO		Complete filting with L. F. Q. Q. Q.			
				Application Number	Not Yet Assigned		
11	IFORMATIC	ON DI	SCLOSURE	Filling Date	Concurrently Herewith		
S	TATEMENT	BY	APPLICANT	First Named Inventor	Mark Duda		
_				Art Unit	N/A		
	(Use as many	sheets as	necessary)	Examiner Name	Not Yet Assigned		
Sheet	2	of	2	Attorney Docket Number	12810-00191-US1		

IL.	WO-97/12674	04-10-1997	Huntsman Petrochemical Corporation	Y
М	WO-97/43242	11-20-1997	Kvaerner Process Technology Limited	7
N	WO-01/68245	09-20-2001	BASF Aktiengesellschaft	
O	WO-01/68626	09-20-2001	BASF Aktiengesellschaft	
P	WO-02/22257	03-21-2002	BASF Aktiengesellschaft	
Q	WO-02/34387	05-02-2002	BASF Aktiengesellschaft	
	N IO	N WO-01/68245 O WO-01/68626 P WO-02/22257	N WO-01/68245 09-20-2001 O WO-01/68626 09-20-2001 P WO-02/22257 03-21-2002	WO-97/43242

EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Drew line through citation if not in conformance and not Texaminer: initial trafference considered, whether or not cation is in conformance with MPEP 603. Draw the timough citation is not conformation to applicant. "CIT one application(s) which are marked with an single asterisk () next to the Cite No. are not supplied (under 37 CFR 1.98(a)(2)(iii)) because that application was filed after June 30, 2003 or is available in the IFW. Applicant's unique citation designation number (optional). See Kinds Codes of USPTO Patent Documents at www.usplo.gog or MPEP 901.04. Enter Office that issued the document, by the two-letter code (WIPO Standard ST.3). For Japanese patent documents, the indication of the year of the reign of the Emperor must precede the serial number of the patent document. Mind of document by the appropriate symbols as indicated on the document under WIPO Standard ST.16 if possible. Applicant is to place a check mark here if English language Translation is attached.

NON PATENT LITERATURE DOCUMENTS					
Examiner Initials	Cite No.1	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T²		
BA	CA	Ullmann's Encyclopedia of Industrial Chemistry, 6th Edition, 2000 Electronic Release, Chapter			
' ///		"Maleic and Fumaric AcidMaleic Anhydride".			

*EXAMINER: Initial if reference considered, whether or not citation is in conformance with MPEP 609. Draw tine through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.

Examiner		Date	
Cionatura	1) 1/2/1	Concident	1/-5/0
Signature		Considered	17
441634		<u> </u>	

Applicant's unique citation designation number (optional). Applicant is to place a check mark here if English language Translation is attached.